TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSII⁻⁵)

2SK1365

Switching Power Supply Applications

Unit: mm

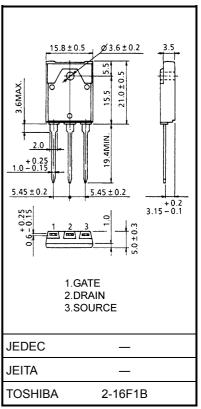
 $\begin{array}{ll} \bullet & Low\ drain-source\ ON\ resistance & : R_{DS}\ (oN) = 1.5\ \Omega\ (typ.) \\ \bullet & High\ forward\ transfer\ admittance & : |Y_{fs}| = 4.0\ S\ (typ.) \\ \bullet & Low\ leakage\ current & : I_{DSS} = 300\ \mu A\ (max)\ (V_{DS} = 800\ V) \\ \bullet & Enhancement-mode & : V_{th} = 1.5 {\sim} 3.5\ V\ (V_{DS} = 10\ V,\ I_D = 1\ mA) \\ \end{array}$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	1000	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	1000	V	
Gate-source voltage		V_{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	7	Α	
	Pulse (Note 1)	I_{DP}	21	A	
Drain power dissipation (Tc = 25°C)		P_{D}	90	W	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.39	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	41.6	°C/W



Weight: 5.8 g (typ.)

Note 1: Please use devices on condition that the channel temperature is below 150°C.

This transistor is an electrostatic sensitive device.

Please handle with caution.

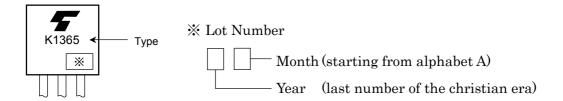
Electrical Characteristics (Ta = 25°C)

Charac	eteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±20 V, V _{DS} = 0 V	_	_	±50	nA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 800 V, V _{GS} = 0 V		_	300	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	1000	_	_	V
Gate threshold v	/oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R _{DS (ON)}	I _D = 4 A, V _{GS} = 10 V	_	1.5	1.8	Ω
Forward transfer	admittance	Y _{fs}	V _{DS} = 20 V, I _D = 4 A	2.0	4.0	_	S
Input capacitano	е	C _{iss}			1300	_	
Reverse transfe	r capacitance	C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	100	_	pF
Output capacita	nce	C _{oss}			180	_	
Switching time -	Rise time	t _r	$V_{GS} = 100 \Omega$ $V_{GS} = 100 \Omega$ $V_{GS} = 100 \Omega$	_	25	_	- ns
	Turn-on time	t _{on}		_	40	_	
	Fall time	t _f		-	20	_	
	Turn-off time	t _{off}	$V_{DD} = 400V$ Duty $\leq 1\%$, $t_{W} = 10 \mu s$	_	100	_	
Total gate charg plus gate-drain)	,		_	120	_		
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 7 \text{ A}$	_	70	_	nC
Gate-drain ("miller") charge Q _{g0}		Q _{gd}			50	_	

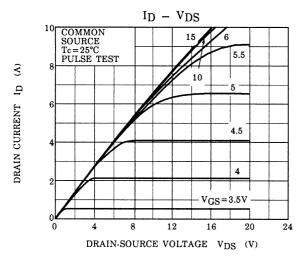
Source-Drain Ratings and Characteristics (Ta = 25°C)

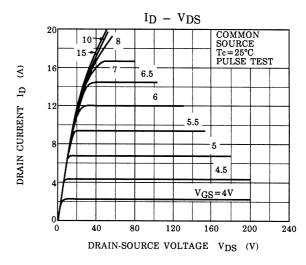
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	7	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	21	Α
Forward voltage (diode)	V_{DSF}	I_{DR} = 7 A, V_{GS} = 0 V	_	_	-1.9	V

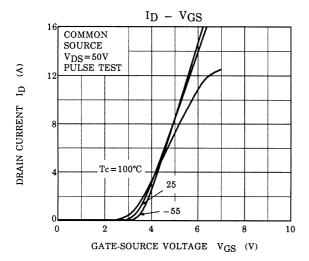
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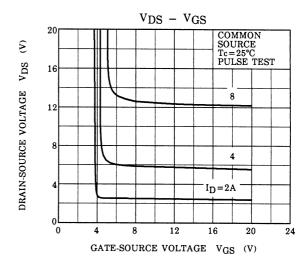


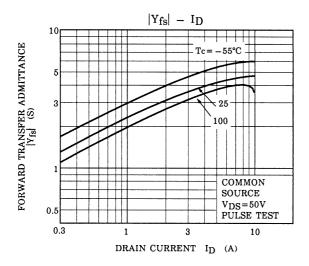
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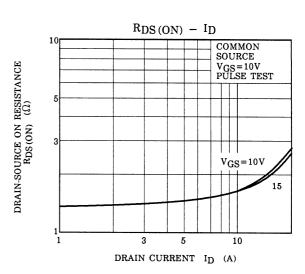




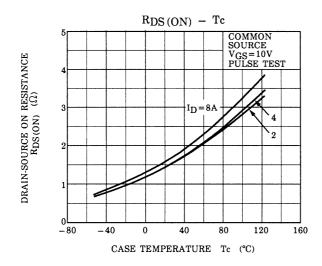


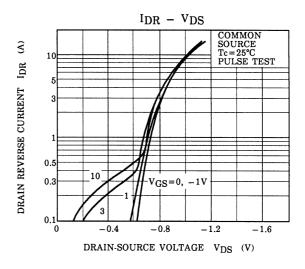


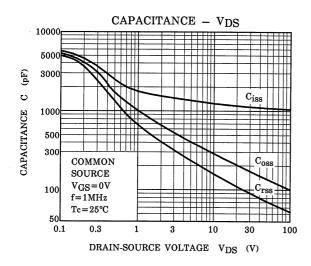


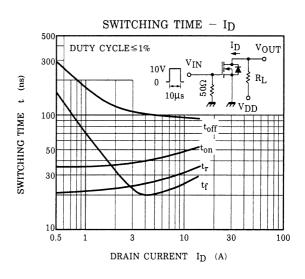


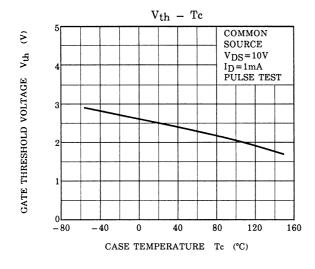
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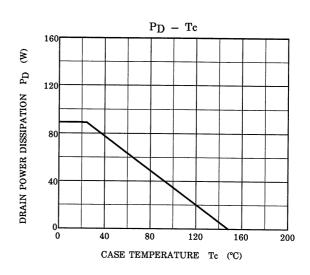




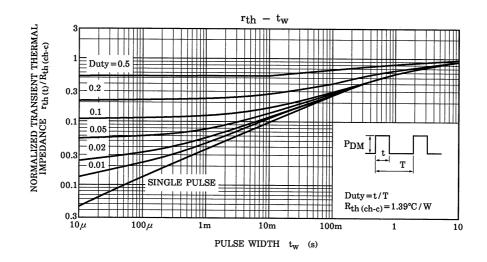


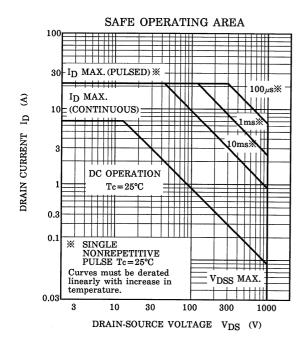






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